Applicant(s)/Patent Under Application/Control No. Reexamination 10/501.080 YOSHIDA, HIROSHI Notice of References Cited Examiner Art Unit Page 1 of 1 Chuong A. Luu 2818 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Ĥ USī US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY EP0502471 A2 03-1992 Japan Shirakawa et al. Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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